

**Notice of References Cited**

Application/Control No.

10/578,026

Applicant(s)/Patent Under  
Reexamination  
VAN BEEK ET AL.

Examiner

KAREN M. KUSUMAKAR

Art Unit

2829

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**U.S. PATENT DOCUMENTS**

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*	B	US-2001/0051302	12-2001	DOVE et al.	430/5
*	C	US-5,949,071	09-1999	Ruffner et al.	250/338.3
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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